

## MWPR1516 16 KB Flash

24 MHz Cortex-M0+ Based Microcontroller

Higher integration receiver controller MCU for wireless power transfer application. Targeting battery powered products are smart phone, tablet, portable medical devices, power tools etc.

This product offers:

- AC/DC conversion and modulation/demodulation circuit for bi-directional communication to support industrial standards with foreign object detection (FOD)
- USB/adaptor power switcher to charge products with wire and wireless with priority.
- Up to 15 W with proper external transistors
- QFN package for industrial application and WLCSP package for space constrained consumer applications

**MWPR1516CFM(R)**  
**MWPR1516CALR**



32-pin QFN (FM) 36-pin WLCSP (AL)  
5 x 5 x 0.58 Pitch 0.5 3.1 x 3.0 x 0.6 Pitch 0.4  
mm mm

### Performance

- 24 MHz ARM® Cortex®-M0+ core
- Single cycle 32-bit x 32-bit multiplier

### Memories and memory interfaces

- 16 KB program flash memory
- 4 KB SRAM

### System peripherals

- LDO provides 5 V and 3 A output to down system
- CNC controls the communication and provides AC protection
- High voltage input PMC module with three power modes: Run, Wait, Stop
- LVR with reset or interrupt, selectable trip points
- WDOG with independent clock source
- Serial wire debug interface

### Clocks

- 32.768 kHz or 4 MHz to 24 MHz crystal oscillator
- Internal 20 kHz low-power oscillator (LPO)
- Internal clock source (ICS)
- Internal FLL with internal or external reference, precision trimming

### Operating Characteristics

- Input from rectifier voltage range: 3.5 to 20 V
- Temperature range (ambient): -40 to 85°C

### Human-machine interface

- One interrupt module (IRQ)
- Up to 13 general-purpose input/output (GPIO)

### Communication interfaces

- One UART module
- One I2C module

### Analog Modules

- One 12-bit analog-to-digital converters (ADC) with up to 4 external channels
- One programmable gain amplifier (PGA) with differential input and output
- One analog comparator (ACMP) containing a 6-bit DAC and programmable reference input

### Timers

- Two 2-channel FTMs with basic TPM function
- One periodic interrupt timers (PIT)
- One FSK demodulation timer (FSKDT)
- System tick timer (SysTick)
- One real time clock (RTC)

### Security and integrity modules

- 80-bit unique identification number per chip

### Ordering Information

| Part Number <sup>1</sup> | Memory     |           | Maximum number of I/O's |
|--------------------------|------------|-----------|-------------------------|
|                          | Flash (KB) | SRAM (KB) |                         |
| MWPR1516CFM(R)           | 16         | 4         | 13                      |
| MWPR1516CALR             | 16         | 4         | 13                      |

1. To confirm current availability of orderable part numbers, go to <http://www.freescale.com> and perform a part number search.

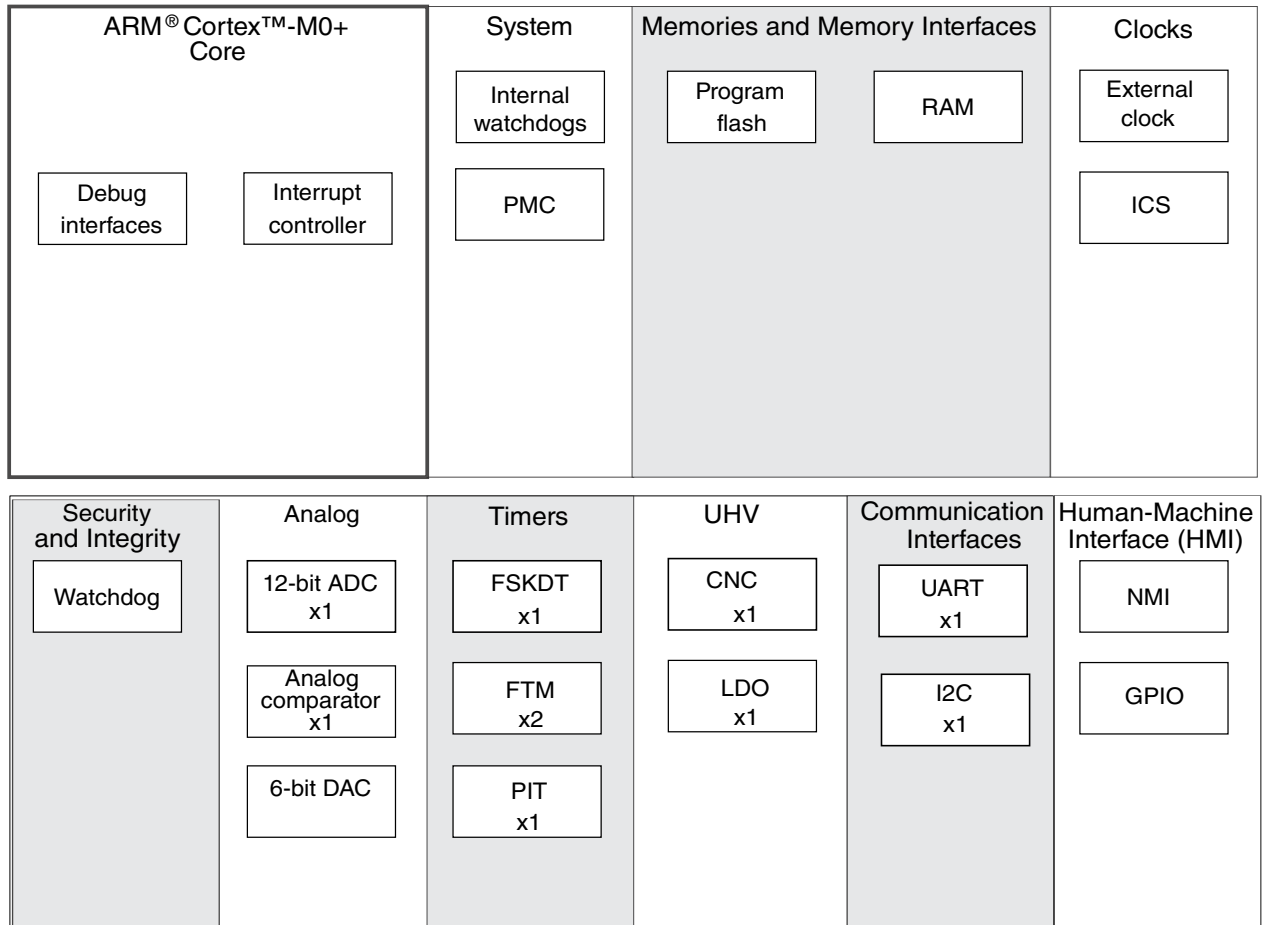
### Related Resources

| Type             | Description                                                                                                                      | Resource                                                                       |
|------------------|----------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------|
| Selector Guide   | The Freescale Solution Advisor is a web-based tool that features interactive application wizards and a dynamic product selector. | <a href="#">Solution Advisor</a>                                               |
| Product Brief    | The Product Brief contains concise overview/summary information to enable quick evaluation of a device for design suitability.   | WPR1516PB <sup>1</sup>                                                         |
| Reference Manual | The Reference Manual contains a comprehensive description of the structure and function (operation) of a device.                 | WPR1516RM <sup>1</sup>                                                         |
| Chip Errata      | The chip mask set Errata provides additional or corrective information for a particular device mask set.                         | WPR1516_0N49M <sup>1</sup>                                                     |
| Package drawing  | Package dimensions are provided in package drawings.                                                                             | QFN 32-pin: 98ASA00615D <sup>1</sup><br>WLCSP 36-pin: 98ASA00789D <sup>1</sup> |

1. To find the associated resource, go to <http://www.freescale.com> and perform a search using this term.

Figure 1 shows the functional modules in the chip.

## WPR1516 Family



**Figure 1. Functional block diagram**

# Table of Contents

|                                                                                     |    |                                                                  |    |
|-------------------------------------------------------------------------------------|----|------------------------------------------------------------------|----|
| 1 Ratings.....                                                                      | 5  | 3.5 Analog.....                                                  | 23 |
| 1.1 Thermal handling ratings.....                                                   | 5  | 3.5.1 IFR measurement conditions.....                            | 23 |
| 1.2 Moisture handling ratings.....                                                  | 5  | 3.5.2 ADC characteristics.....                                   | 24 |
| 1.3 ESD handling ratings.....                                                       | 5  | 3.5.3 Analog comparator (ACMP) electricals.....                  | 26 |
| 1.4 Voltage and current operating ratings.....                                      | 6  | 3.6 Communication interfaces.....                                | 26 |
| 2 General.....                                                                      | 7  | 3.6.1 Inter-Integrated Circuit Interface (I2C) timing.....       | 27 |
| 2.1 Nonswitching electrical specifications.....                                     | 7  | 4 Dimensions.....                                                | 28 |
| 2.1.1 DC electrical characteristics.....                                            | 7  | 4.1 Obtaining package dimensions.....                            | 28 |
| 2.1.2 Supply current characteristics.....                                           | 11 | 5 Pinout.....                                                    | 28 |
| 2.1.3 EMC performance.....                                                          | 12 | 5.1 Signal multiplexing and pin assignments.....                 | 28 |
| 2.2 Switching specifications.....                                                   | 13 | 5.2 Device pin assignment.....                                   | 30 |
| 2.2.1 Control timing.....                                                           | 13 | 6 Ordering Parts.....                                            | 31 |
| 2.2.2 FTM module timing.....                                                        | 14 | 6.1 Determining valid orderable parts.....                       | 31 |
| 2.3 Thermal specifications.....                                                     | 14 | 7 Part Identification.....                                       | 31 |
| 2.3.1 Thermal operating requirements.....                                           | 14 | 7.1 Description.....                                             | 31 |
| 2.3.2 Thermal characteristics.....                                                  | 15 | 7.2 Format.....                                                  | 31 |
| 3 Peripheral operating requirements and behaviors.....                              | 16 | 7.3 Fields.....                                                  | 32 |
| 3.1 UHV modules.....                                                                | 16 | 7.4 Example.....                                                 | 32 |
| 3.1.1 LDO electrical characteristics.....                                           | 16 | 8 Terminology and guidelines.....                                | 32 |
| 3.1.2 Programmable gain amplifier (PGA) electronic<br>characterizations.....        | 17 | 8.1 Definition: Operating requirement.....                       | 32 |
| 3.1.3 Communication and clamp controller (CNC)<br>electronic characterizations..... | 18 | 8.2 Definition: Operating behavior.....                          | 33 |
| 3.2 Core modules.....                                                               | 19 | 8.3 Definition: Attribute.....                                   | 33 |
| 3.2.1 SWD electricals .....                                                         | 19 | 8.4 Definition: Rating.....                                      | 34 |
| 3.3 Clock modules.....                                                              | 20 | 8.5 Result of exceeding a rating.....                            | 34 |
| 3.3.1 External oscillator (OSC) and ICS characteristics.....                        | 20 | 8.6 Relationship between ratings and operating requirements..... | 35 |
| 3.4 Memories and memory interfaces.....                                             | 22 | 8.7 Guidelines for ratings and operating requirements.....       | 35 |
| 3.4.1 NVM specifications.....                                                       | 22 | 8.8 Definition: Typical value.....                               | 35 |
|                                                                                     |    | 8.9 Typical value conditions.....                                | 36 |
|                                                                                     |    | 9 Revision history.....                                          | 37 |

# 1 Ratings

## 1.1 Thermal handling ratings

| Symbol           | Description                   | Min. | Max. | Unit | Notes |
|------------------|-------------------------------|------|------|------|-------|
| T <sub>STG</sub> | Storage temperature           | −55  | 150  | °C   | 1     |
| T <sub>SDR</sub> | Solder temperature, lead-free | —    | 260  | °C   | 2     |

1. Determined according to JEDEC Standard JESD22-A103, *High Temperature Storage Life*.
2. Determined according to IPC/JEDEC Standard J-STD-020, *Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices*.

## 1.2 Moisture handling ratings

| Symbol | Description                | Min. | Max. | Unit | Notes |
|--------|----------------------------|------|------|------|-------|
| MSL    | Moisture sensitivity level | —    | 3    | —    | 1     |

1. Determined according to IPC/JEDEC Standard J-STD-020, *Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices*.

## 1.3 ESD handling ratings

| Symbol           | Description <sup>1</sup>                              | Min   | Typ. | Max   | Unit | Notes |
|------------------|-------------------------------------------------------|-------|------|-------|------|-------|
| V <sub>HBM</sub> | Electrostatic discharge voltage, human body model     | -2000 | —    | +2000 | V    | 2     |
| V <sub>CDM</sub> | Electrostatic discharge voltage, charged-device model | -500  | —    | +500  | V    | 3     |
| I <sub>LAT</sub> | Latch-up current at ambient temperature of 85 °C      | -100  | —    | +100  | mA   | 4     |

1. Parameter is achieved by design characterization on a small sample size from typical devices under typical conditions, unless otherwise noted.
2. Determined according to JEDEC Standard JESD22-A114, *Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)*.
3. Determined according to JEDEC Standard JESD22-C101, *Field-Induced Charged-Device Model Test Method for Electrostatic-Discharge-Withstand Thresholds of Microelectronic Components*.
4. Determined according to JEDEC Standard JESD78, *IC Latch-Up Test*.

## 1.4 Voltage and current operating ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond the limits specified in the following table may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this document.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either  $V_{SS}$  or  $V_{DD}$ ) or the programmable pullup resistor associated with the pin is enabled.

**Table 1. Voltage and current operating ratings**

| Symbol        | Description                                                                                                                                                                                                                              | Min. | Max.         | Unit |
|---------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|--------------|------|
| $V_{REC}$     | Supply voltage from wireless receiver rectifier                                                                                                                                                                                          | 0    | 20           | V    |
| $V_{AC1/AC2}$ | AC voltage input from wireless receiver coil                                                                                                                                                                                             | -0.3 | 21           | V    |
| $I_{VREC}$    | Maximum current into $V_{REC}$                                                                                                                                                                                                           | 0    | 120          | mA   |
| $V_{DIO}$     | Digital input voltage (except $RESET\_b$ , $EXTAL$ , and $XTAL$ )                                                                                                                                                                        | -0.3 | $V_{DD}+0.3$ | V    |
| $V_{AD\_IN}$  | Wired power input voltage                                                                                                                                                                                                                | 0    | 12           |      |
| $V_{AIO}$     | <ul style="list-style-type: none"> <li>Analog<sup>1</sup>, <math>RESET</math>, <math>VOUT\_FB</math>, <math>EXTAL</math>, and <math>XTAL</math> input voltage</li> <li><math>VOUT</math> and <math>ISENS</math> input voltage</li> </ul> | -0.3 | $V_{DD}+0.3$ |      |
| $I_D$         | Instantaneous maximum current single pin limit                                                                                                                                                                                           | -0.3 | 5.5          | mA   |
|               |                                                                                                                                                                                                                                          | -25  | 25           |      |
|               | • for GPIO pins                                                                                                                                                                                                                          | -10  | 10           |      |
|               | • for other pins except power pins                                                                                                                                                                                                       |      |              |      |

1. Analog pins are defined as pins that do not have an associated general-purpose I/O port function.

## 2 General

### 2.1 Nonswitching electrical specifications

#### 2.1.1 DC electrical characteristics

This section includes information about power supply requirements and I/O pin characteristics.

**Table 2. DC characteristics**

| Symbol              | Descriptions                                        |                                         |                                                      | Min.                   | Typical <sup>1</sup> | Max.                   | Unit |
|---------------------|-----------------------------------------------------|-----------------------------------------|------------------------------------------------------|------------------------|----------------------|------------------------|------|
| —                   | Operating voltage                                   |                                         |                                                      | 3.13                   | —                    | 5.5                    | V    |
| V <sub>OH</sub>     | Output high voltage                                 | All I/O pins, standard-drive strength   | 5 V, I <sub>load</sub> = -5 mA                       | V <sub>DD</sub> - 0.8  | —                    | —                      | V    |
| I <sub>OHT</sub>    | Output high current                                 | Max total I <sub>OH</sub> for all ports | 5 V                                                  | —                      | —                    | -100                   | mA   |
| V <sub>OL</sub>     | Output low voltage                                  | All I/O pins, standard-drive strength   | 5 V, I <sub>load</sub> = 5 mA                        | —                      | —                    | 0.8                    | V    |
| I <sub>OLT</sub>    | Output low current                                  | Max total I <sub>OL</sub> for all ports | 5 V                                                  | —                      | —                    | 100                    | mA   |
| V <sub>IH</sub>     | Input high voltage                                  | All digital inputs                      | V <sub>DD</sub> > 4.5 V                              | 0.70 × V <sub>DD</sub> | —                    | —                      | V    |
| V <sub>IH</sub>     | Input high voltage                                  | All digital inputs                      | 3.13 V < V <sub>DD</sub> ≤ 4.5 V                     | 0.75 × V <sub>DD</sub> | —                    | —                      | V    |
| V <sub>IL</sub>     | Input low voltage                                   | All digital inputs                      | 3.13 V < V <sub>DD</sub> ≤ 4.5 V                     | —                      | —                    | 0.30 × V <sub>DD</sub> | V    |
| V <sub>IL</sub>     | Input low voltage                                   | All digital inputs                      | V <sub>DD</sub> > 3.3 V                              | —                      | —                    | 0.35 × V <sub>DD</sub> | V    |
| V <sub>hys</sub>    | Input hysteresis                                    | All digital inputs                      | —                                                    | 0.06 × V <sub>DD</sub> | —                    | —                      | mV   |
| I <sub>Iin</sub>    | Input leakage current                               | All input only pins (per pin)           | V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub> | —                      | 0.1                  | 1                      | μA   |
| I <sub>Ioz</sub>    | Hi-Z (off-state) leakage current                    | All input / output (per pin)            | V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub> | —                      | 0.1                  | 1                      | μA   |
| I <sub>IozTOT</sub> | Total leakage combined for all inputs and Hi-Z pins | All input only and I/O                  | V <sub>IN</sub> = V <sub>DD</sub> or V <sub>SS</sub> | —                      | —                    | 2                      | μA   |

*Table continues on the next page...*

**Table 2. DC characteristics (continued)**

| Symbol                       | Descriptions                               |                                                                         |                                                                          | Min. | Typical <sup>1</sup> | Max. | Unit |
|------------------------------|--------------------------------------------|-------------------------------------------------------------------------|--------------------------------------------------------------------------|------|----------------------|------|------|
| R <sub>PU</sub>              | Pullup resistors                           | All digital inputs, when enabled (all I/O pins other than PTA6 or PTA7) | —                                                                        | 30.0 | —                    | 50.0 | kΩ   |
| R <sub>PU</sub> <sup>2</sup> | Pullup resistors                           | PTA6 and PTA7                                                           | —                                                                        | 30.0 | —                    | 60.0 | kΩ   |
| I <sub>IC</sub>              | DC injection current <sup>3, 4, 5, 6</sup> | Single pin limit                                                        | V <sub>IN</sub> < V <sub>SS</sub> ,<br>V <sub>IN</sub> > V <sub>DD</sub> | -0.2 | —                    | 2    | mA   |
|                              |                                            | Total MCU limit, includes sum of all stressed pins                      |                                                                          | -5   | —                    | 25   |      |
| C <sub>In</sub>              | Input capacitance, all pins                |                                                                         | —                                                                        | —    | —                    | 7    | pF   |
| V <sub>RAM</sub>             | RAM retention voltage                      |                                                                         | —                                                                        | 2.0  | —                    | —    | V    |

1. Typical values are measured at 25 °C. Characterized, not tested.
2. The specified resistor value is the actual value internal to the device. The pullup value may appear higher when measured externally on the pin.
3. This item applies to the GPIO share pads only.
4. All functional non-supply pins, except for PTA6 and PTA7, are internally clamped to V<sub>DD</sub>.
5. Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the large one.
6. Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If the positive injection current (V<sub>IN</sub> > V<sub>DD</sub>) is higher than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Ensure that external V<sub>DD</sub> load will shunt current higher than maximum injection current when the MCU is not consuming power, such as no system clock is present, or clock rate is very low (which would reduce overall power consumption).

**Table 3. Power supply electrical characteristics**

| Symbol                       | Description                      |                                                        | Min.            | Typical <sup>1</sup>  | Max.            | Unit |
|------------------------------|----------------------------------|--------------------------------------------------------|-----------------|-----------------------|-----------------|------|
| V <sub>DD1.8</sub>           | Output voltage core              | Full performance mode                                  | 1.72            | 1.83                  | 1.98            | V    |
|                              |                                  | Reduced power mode <sup>2</sup>                        | —               | 1.6                   | —               | V    |
| V <sub>DDF</sub>             | Output Voltage Flash             | Full performance mode                                  | 2.6             | 2.81                  | 2.9             | V    |
|                              |                                  | Reduced power mode <sup>2</sup>                        | —               | 1.69                  | —               | V    |
| V <sub>DD</sub> <sup>3</sup> | Output voltage V <sub>DD</sub>   | Full performance mode 3.5 V ≤ V <sub>REC</sub> < 4.5 V | 3.13            | —                     | 4.5             | V    |
|                              |                                  | Full performance mode 4.5 V ≤ V <sub>REC</sub> < 5.3 V | 4.19            | —                     | 5.25            | V    |
|                              |                                  | Full performance mode V <sub>REC</sub> ≥ 5.3 V         | 4.75            | 4.99                  | 5.25            | V    |
|                              |                                  | Reduced power mode <sup>2</sup>                        | 2.5             | —                     | 5.75            | V    |
| I <sub>DD</sub>              | Load current V <sub>DD</sub>     | Full performance mode 3.5 V ≤ V <sub>REC</sub> < 4.5 V | 0               | —                     | 28              | mA   |
|                              |                                  | Full performance mode 4.5 V ≤ V <sub>REC</sub> < 5.3 V | 0               | —                     | 28              | mA   |
|                              |                                  | Full performance mode V <sub>REC</sub> ≥ 5.3 V         | 0               | —                     | 50              | mA   |
|                              |                                  | Reduced power mode <sup>2</sup>                        | 0               | —                     | 5               | mA   |
| V <sub>REFH</sub>            | Output voltage V <sub>REFH</sub> | 4.1 V ≤ V <sub>REC</sub> < 4.5 V                       | 3.781           | 3.8                   | 3.819           | V    |
|                              |                                  | 4.5 V ≤ V <sub>REC</sub> < 4.9 V                       | 3.781/<br>4.179 | 3.8/ 4.2 <sup>4</sup> | 3.819/<br>4.221 | V    |

Table continues on the next page...



**Table 3. Power supply electrical characteristics (continued)**

| Symbol         | Description                                                         | Min.                                                 | Typical <sup>1</sup>          | Max.                      | Unit                 |
|----------------|---------------------------------------------------------------------|------------------------------------------------------|-------------------------------|---------------------------|----------------------|
|                | $V_{REC} \geq 4.9 \text{ V}$                                        | 3.781/<br>4.179/<br>4.577                            | 3.8/ 4.2/<br>4.6 <sup>4</sup> | 3.819/<br>4.221/<br>4.623 | V                    |
| —              | $V_{REFH}$ accuracy                                                 | $V_{REC} \geq V_{REFH} + 0.3, 0-70^\circ \text{C}$   | —                             | 0.5                       | %                    |
|                |                                                                     | $V_{REC} \geq V_{REFH} + 0.3, -40-85^\circ \text{C}$ | —                             | 0.8                       | %                    |
| $I_{REFH}$     | Output current<br>$V_{REFH}$                                        | $V_{REC} \geq V_{REFH} + 0.3$                        | 0                             | —                         | 5 mA                 |
| $V_{LVWA}$     | $V_{DD}$ Low voltage<br>warning assert level                        | PMC_LVCTLSTAT1[SLVWSEL] = 0b                         | 3.43                          | 3.63                      | 3.83 V               |
|                |                                                                     | PMC_LVCTLSTAT1[SLVWSEL] = 1b                         | 3.94                          | 4.14                      | 4.34                 |
| $V_{LVWD}$     | $V_{DD}$ Low voltage<br>warning deassert<br>level                   | PMC_LVCTLSTAT1[SLVWSEL] = 0b                         | 3.54                          | 3.74                      | 3.94 V               |
|                |                                                                     | PMC_LVCTLSTAT1[SLVWSEL] = 1b                         | 4.08                          | 4.28                      | 4.48                 |
| $V_{LVRA}$     | $V_{DD}$ low voltage reset assert                                   |                                                      | 2.97                          | 3.02                      | — V                  |
| $V_{LVRD}$     | $V_{DD}$ low voltage reset deassertl                                |                                                      | —                             | —                         | 3.13 V               |
| $V_{LVWREFHA}$ | Low voltage warning<br>for $V_{REFH}$ assert<br>level               | PMC_VREFHLVW[LVWCFG]=00b                             | 3.34                          | 3.54                      | 3.74 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=01b                             | 3.43                          | 3.63                      | 3.83 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=10b                             | 3.86                          | 4.06                      | 4.26 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=11b                             | 4.11                          | 4.31                      | 4.51 V               |
| $V_{LVWREFHA}$ | Low voltage warning<br>for $V_{REFH}$ deassert<br>level             | PMC_VREFHLVW[LVWCFG]=00b                             | 3.45                          | 3.65                      | 3.85 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=01b                             | 3.55                          | 3.75                      | 3.95 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=10b                             | 4.00                          | 4.20                      | 4.40 V               |
|                |                                                                     | PMC_VREFHLVW[LVWCFG]=11b                             | 4.27                          | 4.47                      | 4.67 V               |
| $V_{LVR1.8A}$  | Low voltage reset for $V_{DD1.8}$ assert level                      |                                                      | 1.49                          | 1.69                      | 1.89 V               |
| $V_{LVR1.8D}$  | Low voltage reset for $V_{DD1.8}$ deassert level                    |                                                      | 1.56                          | 1.76                      | 1.96 V               |
| $V_{LVRDDFA}$  | Low voltage reset for $V_{DDF}$ assert level                        |                                                      | 2.44                          | 2.64                      | 2.84 V               |
| $V_{LVRDDFD}$  | Low voltage reset for $V_{DDF}$ deassert level                      |                                                      | 2.52                          | 2.72                      | 2.92 V               |
| $f_{LPOCLK}$   | Trimmed LPOCLK output frequency                                     | —                                                    | 20                            | —                         | kHz                  |
| $df_{LPOCLK}$  | Trimmed LPOCLK internal clock $\Delta f / f_{NOMINAL}$ <sup>5</sup> | -5                                                   | —                             | 5                         | %                    |
| $t_{SDEL}$     | LPOCLK start up delay                                               | —                                                    | 25                            | 50                        | $\mu\text{s}$        |
| $dV_{HT}$      | Temperature sensor slope                                            | —                                                    | 5.07                          | —                         | mV/ $^\circ\text{C}$ |
| $V_{HT}$       | Temperature sensor output voltage                                   | —                                                    | 1.57                          | —                         | V                    |
| $T_{HTIA}$     | High temperature interrupt assert <sup>6</sup>                      | 95                                                   | 110                           | 125                       | $^\circ\text{C}$     |
| $T_{HTID}$     | High temperature interrupt deassert <sup>6</sup>                    | 85                                                   | 100                           | 115                       | $^\circ\text{C}$     |
| $V_{BG}$       | Bandgap output voltage                                              | 1.13                                                 | 1.2                           | 1.32                      | V                    |
| $V_{HCBG}$     | HC Bandgap output voltage                                           | 1.14                                                 | 1.15                          | 1.16                      | V                    |
| $t_{STP\_REC}$ | Recovery time from<br>Stop                                          | not including $V_{REFH}$                             | —                             | 15                        | $\mu\text{s}$        |
|                |                                                                     | including $V_{REFH}$                                 | —                             | 1                         | ms                   |

1. Typical values are measured at 25  $^\circ\text{C}$ .

## Nonswitching electrical specifications

2. Power supply enters reduced power mode when MCU is in Stop mode.
3.  $V_{DD}$  is from  $V_{DD1}$ .
4. This typical value is configurable based on  $V_{REC}$ .
5. User need to trim the LPOCLK in order to get  $\pm 5\%$  LPOCLK
6. This is junction temperature.

### NOTE

Unless noted,  $V_{DD1}$  and  $V_{DD2}$  must be shorted on the application board.

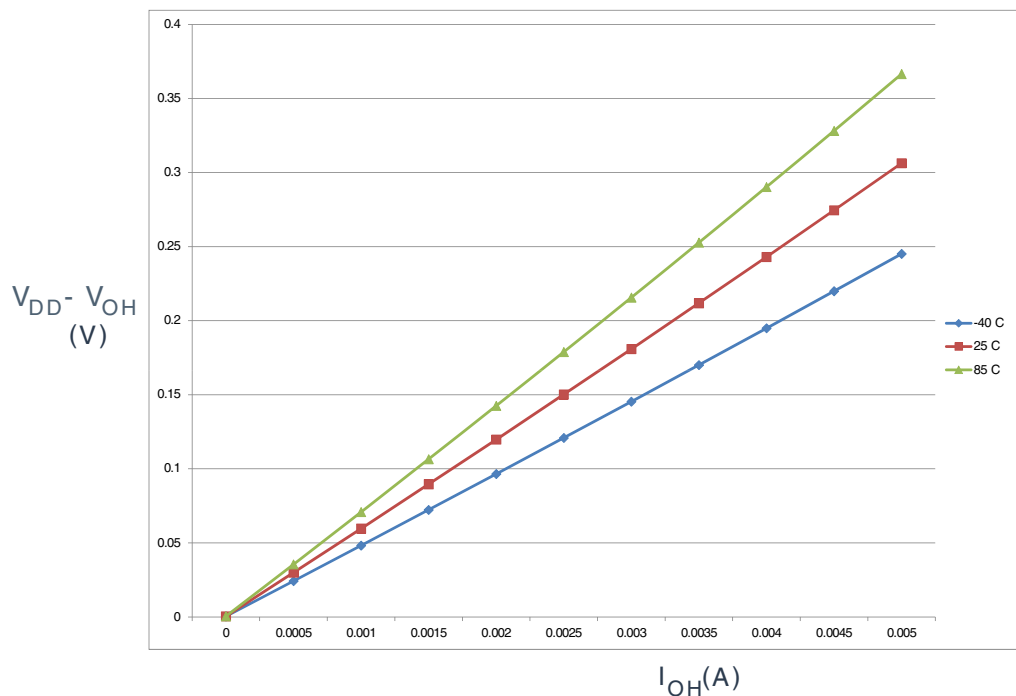


Figure 2. Typical  $I_{OH}$  Vs.  $V_{DD} - V_{OH}$  (standard drive strength) ( $V_{DD} = 5$  V)

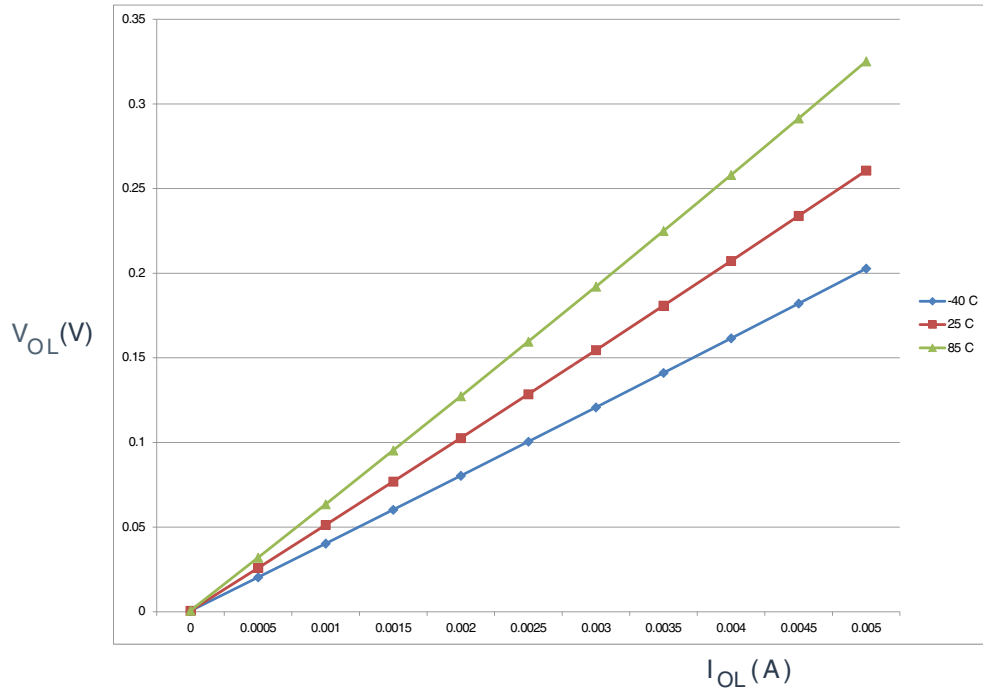


Figure 3. Typical  $I_{OL}$  Vs.  $V_{OL}$  (standard drive strength) ( $V_{DD} = 5$  V)

## 2.1.2 Supply current characteristics

This section includes information about power supply current in various operating modes.

Table 4. Supply current characteristics (at 5.5 V)

| Parameter                                                                | Symbol    | Bus Freq. | Typical <sup>1</sup> | Max. | Unit | Temp.     |
|--------------------------------------------------------------------------|-----------|-----------|----------------------|------|------|-----------|
| Run supply current FEI mode, all modules clocks enabled; run from flash  | $RI_{DD}$ | 24 MHz    | 13.17                | —    | mA   | -40–85 °C |
|                                                                          |           | 12 MHz    | 9.37                 | —    |      |           |
|                                                                          |           | 6 MHz     | 7.49                 | —    |      |           |
| Run supply current FEI mode, all modules clocks disabled; run from flash | $RI_{DD}$ | 24 MHz    | 11.17                | —    | mA   | -40–85 °C |
|                                                                          |           | 12 MHz    | 8.37                 | —    |      |           |
|                                                                          |           | 6 MHz     | 6.99                 | —    |      |           |
| Run supply current FBE mode, all modules clocks enabled; run from RAM    | $RI_{DD}$ | 24 MHz    | 14.01                | 17   | mA   | -40–85 °C |
|                                                                          |           | 12 MHz    | 8.65                 | —    |      |           |
|                                                                          |           | 6 MHz     | 6.60                 | —    |      |           |
| Run supply current FBE mode, all modules clocks disabled; run from RAM   | $RI_{DD}$ | 24 MHz    | 10.61                | 13   | mA   | -40–85 °C |
|                                                                          |           | 12 MHz    | 7.65                 | —    |      |           |
|                                                                          |           | 6 MHz     | 6.09                 | —    |      |           |
| Wait mode current FBE mode, all modules clocks enabled                   | $WI_{DD}$ | 24 MHz    | 8.23                 | 10   | mA   | -40–85 °C |

Table continues on the next page...

**Table 4. Supply current characteristics (at 5.5 V) (continued)**

| Parameter                                                    | Symbol           | Bus Freq. | Typical <sup>1</sup> | Max. | Unit | Temp.     |
|--------------------------------------------------------------|------------------|-----------|----------------------|------|------|-----------|
|                                                              |                  | 12 MHz    | 6.52                 | —    |      |           |
|                                                              |                  | 6 MHz     | 5.53                 | —    |      |           |
| Stop mode supply current no clocks active (except CNC clock) | SI <sub>DD</sub> | —         | 700                  | —    | μA   | -40–85 °C |

1. Data in Typical column was characterized at 25 °C or is typical recommended value.

## 2.1.3 EMC performance

Electromagnetic compatibility (EMC) performance is highly dependent on the environment in which the MCU resides. Board design and layout, circuit topology choices, location and characteristics of external components as well as MCU software operation play a significant role in EMC performance. The system designer must consult the following Freescale applications notes, available on [freescale.com](http://freescale.com) for advice and guidance specifically targeted at optimizing EMC performance.

- AN2321: Designing for Board Level Electromagnetic Compatibility
- AN1050: Designing for Electromagnetic Compatibility (EMC) with HCMOS Microcontrollers
- AN1263: Designing for Electromagnetic Compatibility with Single-Chip Microcontrollers
- AN2764: Improving the Transient Immunity Performance of Microcontroller-Based Applications
- AN1259: System Design and Layout Techniques for Noise Reduction in MCU-Based Systems

### 2.1.3.1 Radiated Emissions

**Table 5. EMC radiated emissions operating behaviors for 32-pin QFN package**

| Symbol              | Description                        | Frequency band (MHz) | Typ. | Unit | Notes |
|---------------------|------------------------------------|----------------------|------|------|-------|
| V <sub>RE1</sub>    | Radiated emissions voltage, band 1 | 0.15–50              | 4    | dBμV | 1, 2  |
| V <sub>RE2</sub>    | Radiated emissions voltage, band 2 | 50–150               | 6    | dBμV |       |
| V <sub>RE3</sub>    | Radiated emissions voltage, band 3 | 150–500              | 16   | dBμV |       |
| V <sub>RE4</sub>    | Radiated emissions voltage, band 4 | 500–1000             | 5    | dBμV |       |
| V <sub>RE_IEC</sub> | IEC level                          | 0.15–1000            | M    | —    | 2, 3  |

1. Determined according to IEC Standard 61967-1, *Integrated Circuits - Measurement of Electromagnetic Emissions, 150 kHz to 1 GHz Part 1: General Conditions and Definitions* and IEC Standard 61967-2, *Integrated Circuits - Measurement of Electromagnetic Emissions, 150 kHz to 1 GHz Part 2: Measurement of Radiated Emissions—TEM Cell and Wideband TEM Cell Method*. Measurements were made while the microcontroller was running basic application code. The reported emission level is the value of the maximum measured emission, rounded up to the next whole number, from among the measured orientations in each frequency range.
2.  $V_{RECT} = 5.0\text{ V}$ ,  $T_A = 25\text{ °C}$ ,  $f_{OSC} = 32.768\text{ kHz}$  (crystal),  $f_{SYS} = 24\text{ MHz}$ ,  $f_{BUS} = 24\text{ MHz}$
3. Specified according to Annex D of IEC Standard 61967-2, *Measurement of Radiated Emissions—TEM Cell and Wideband TEM Cell Method*

## 2.2 Switching specifications

### 2.2.1 Control timing

Table 6. Control Timing

| Rating                                                         |                                | Symbol       | Min.                 | Typical <sup>1</sup> | Max. | Unit |
|----------------------------------------------------------------|--------------------------------|--------------|----------------------|----------------------|------|------|
| Bus frequency ( $t_{CYC} = 1 / f_{BUS}$ )                      |                                | $f_{BUS}$    | DC                   | —                    | 24   | MHz  |
| Internal low power oscillator frequency <sup>2</sup>           |                                | $f_{LPO}$    | 16                   | 20                   | 26   | KHz  |
| External reset pulse width                                     |                                | $t_{EXTRST}$ | $1.5 \times t_{CYC}$ | —                    | —    | ns   |
| Reset low drive                                                |                                | $t_{RSTDRV}$ | $34 \times t_{CYC}$  | —                    | —    | ns   |
| External NMI pin interrupt pulse width - Asynchronous path     |                                | $t_{NMI}$    | 100                  | —                    | —    | ns   |
| IRQ pulse width                                                | Asynchronous path <sup>3</sup> | $t_{ILIH}$   | 100                  | —                    | —    | ns   |
|                                                                | Synchronous path               | $t_{IHIL}$   | $1.5 \times t_{CYC}$ | —                    | —    | ns   |
| Port rise and fall time - Normal drive strength (load = 50 pF) | —                              | $t_{Rise}$   | —                    | 10.2                 | —    | ns   |
|                                                                |                                | $t_{Fall}$   | —                    | 9.5                  | —    | ns   |

1. Typical values are based on characterization data at  $V_{DD} = 5.0\text{ V}$ ,  $25\text{ °C}$  unless otherwise stated.
2. It can be configured by `PMC_RC20KTRM[OSCOT]`.
3. This is the shortest pulse that is guaranteed to be recognized as a IRQ pin request.

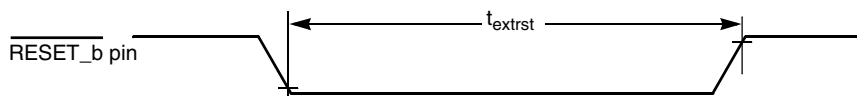
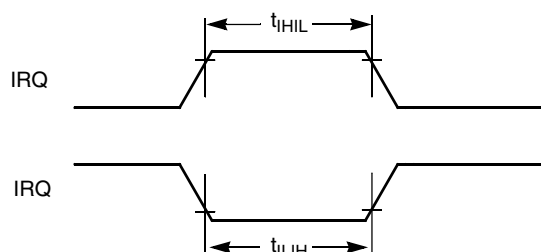


Figure 4. Reset Timing

## Thermal specifications



**Figure 5. IRQ Timing**

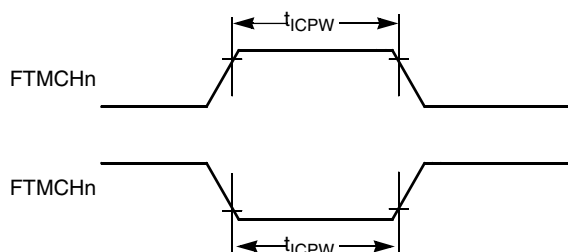
### 2.2.2 FTM module timing

Synchronizer circuits determine the shortest input pulses that can be recognized. These synchronizers operate from the timer clock.

**Table 7. FTM Input Timing**

| Function                  | Symbol     | Min. | Max. | Unit          |
|---------------------------|------------|------|------|---------------|
| Input capture pulse width | $t_{ICPW}$ | 1.5  | —    | $t_{Timer}^1$ |

1.  $t_{Timer} = 1/f_{Timer}$



**Figure 6. Timer Input Capture Pulse**

## 2.3 Thermal specifications

### 2.3.1 Thermal operating requirements

**Table 8. Thermal operating requirements of WLCSP package**

| Symbol | Description              | Min. | Max | Unit | Notes |
|--------|--------------------------|------|-----|------|-------|
| $T_J$  | Die junction temperature | -40  | 95  | °C   |       |
| $T_A$  | Ambient temperature      | -40  | 85  | °C   | 1     |

1. Maximum  $T_A$  can be exceeded only if the user ensures that  $T_J$  does not exceed the maximum. The simplest method to determine  $T_J$  is:  $T_J = T_A + \theta_{JA} \times \text{chip power dissipation}$ .

**Table 9. Thermal operating requirements of QFN package**

| Symbol | Description              | Min. | Max | Unit | Notes |
|--------|--------------------------|------|-----|------|-------|
| $T_J$  | Die junction temperature | -40  | 105 | °C   |       |
| $T_A$  | Ambient temperature      | -40  | 85  | °C   | 1     |

1. Maximum  $T_A$  can be exceeded only if the user ensures that  $T_J$  does not exceed the maximum. The simplest method to determine  $T_J$  is:  $T_J = T_A + \theta_{JA} \times \text{chip power dissipation}$ .

### 2.3.2 Thermal characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To take  $P_{I/O}$  into account in power calculations, determine the difference between actual pin voltage and  $V_{SS}$  or  $V_{DD}$  and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and  $V_{SS}$  or  $V_{DD}$  will be very small.

**Table 10. Thermal Attributes**

| Board type        | Symbol           | Description                                                                                        | 32 QFN | 36 WLCSP | Unit | Notes |
|-------------------|------------------|----------------------------------------------------------------------------------------------------|--------|----------|------|-------|
| Single-layer (1S) | $R_{\theta JA}$  | Thermal resistance, junction to ambient (natural convection)                                       | 97     | 129.8    | °C/W | 1, 2  |
| Four-layer (2s2p) | $R_{\theta JA}$  | Thermal resistance, junction to ambient (natural convection)                                       | 33     | 71.4     | °C/W | 1, 3  |
| Single-layer (1S) | $R_{\theta JMA}$ | Thermal resistance, junction to ambient (200 ft./min. air speed)                                   | 81     | 116.5    | °C/W | 1, 3  |
| Four-layer (2s2p) | $R_{\theta JMA}$ | Thermal resistance, junction to ambient (200 ft./min. air speed)                                   | 27     | 68.0     | °C/W | 1, 3  |
| —                 | $R_{\theta JB}$  | Thermal resistance, junction to board                                                              | 12     | 48.6     | °C/W | 4     |
| —                 | $R_{\theta JC}$  | Thermal resistance, junction to case                                                               | 1.3    | 8.1      | °C/W | 5     |
| —                 | $\Psi_{JT}$      | Thermal characterization parameter, junction to package top outside center (natural convection)    | 3      | 0.2      | °C/W | 6     |
| —                 | $\Psi_{JB}$      | Thermal characterization parameter, junction to package bottom outside center (natural convection) | —      | 14.3     | °C/W | 7     |

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

## Peripheral operating requirements and behaviors

2. JESD51-2 with the single layer board (JESD51-3) horizontal.
3. Per JEDEC JESD51-6 with the board (JESD51-7) horizontal.
4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
5. Thermal resistance between the die and the solder pad on the bottom of the package. Interface resistance is ignored.
6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.
7. Thermal characterization parameter indicating the temperature difference between package bottom center and the junction temperature per JEDEC JESD51-12. When Greek letters are not available, the thermal characterization parameter is written as Psi-JB.

The average chip-junction temperature ( $T_J$ ) in °C can be obtained from:

$$T_J = T_A + (P_D \times \theta_{JA})$$

Where:

$T_A$  = Ambient temperature, °C

$\theta_{JA}$  = Package thermal resistance, junction-to-ambient, °C/W

$$P_D = P_{INT} + P_{I/O}$$

$P_{INT} = I_{DD} \times V_{DD}$ , Watts - chip internal power

$P_{I/O}$  = Power dissipation on input and output pins - user determined

For most applications,  $P_{I/O} \ll P_{INT}$  and can be neglected. An approximate relationship between  $P_D$  and  $T_J$  (if  $P_{I/O}$  is neglected) is:

$$P_D = K \div (T_J + 273 \text{ °C})$$

Solving the equations above for K gives:

$$K = P_D \times (T_A + 273 \text{ °C}) + \theta_{JA} \times (P_D)^2$$

Where K is a constant pertaining to the particular part. K can be determined by measuring  $P_D$  (at equilibrium) for an known  $T_A$ . Using this value of K, the values of  $P_D$  and  $T_J$  can be obtained by solving the above equations iteratively for any value of  $T_A$ .

## 3 Peripheral operating requirements and behaviors

### 3.1 UHV modules



### 3.1.1 LDO electrical characteristics

This section provides data about the LDO module electrical characteristics.

**Table 11. LDO electrical characteristics**

| Sy<br>mb<br>ol        | Description                                                                                                                                                                                                               | Min.       | Typical                                                                                                                                                                                                                                                                              | Max. | Unit |
|-----------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|
| V <sub>OUT</sub><br>1 | Regulated output voltage                                                                                                                                                                                                  | 4.2        | 5                                                                                                                                                                                                                                                                                    | 5.2  | V    |
| V <sub>OUT</sub><br>A | Output voltage accuracy                                                                                                                                                                                                   | —          | 2 <sup>2</sup>                                                                                                                                                                                                                                                                       | —    | %    |
| V <sub>TH1</sub>      | Over voltage protection de-assert<br>LDO_CR[OVTHLD]=00b<br>LDO_CR[OVTHLD]=01b<br>LDO_CR[OVTHLD]=10b<br>LDO_CR[OVTHLD]=11b                                                                                                 | —          | 4.27<br>4.62<br>5.33<br>5.78                                                                                                                                                                                                                                                         | —    | V    |
| V <sub>TH2</sub>      | Over voltage protection assert<br>LDO_CR[OVTHLD]=00b<br>LDO_CR[OVTHLD]=01b<br>LDO_CR[OVTHLD]=10b<br>LDO_CR[OVTHLD]=11b                                                                                                    | —          | 4.8<br>5.2<br>6.0<br>6.5                                                                                                                                                                                                                                                             | —    | V    |
| I <sub>LIM</sub>      | Current limit threshold, with sample resistor:<br>33 mΩ<br>100 mΩ                                                                                                                                                         | 0.3<br>0.1 | N x 1.4/(511 x 10 x R <sub>sense</sub> ) <sup>3</sup>                                                                                                                                                                                                                                | —    | A    |
| I <sub>TH1</sub>      | Over current protection threshold<br>LDO_CR[OCTHLD]=000b<br>LDO_CR[OCTHLD]=001b<br>LDO_CR[OCTHLD]=010b<br>LDO_CR[OCTHLD]=011b<br>LDO_CR[OCTHLD]=100b<br>LDO_CR[OCTHLD]=101b<br>LDO_CR[OCTHLD]=110b<br>LDO_CR[OCTHLD]=111b | —          | 1.05/(10 x R <sub>sense</sub> )<br>1.10/(10 x R <sub>sense</sub> )<br>1.15/(10 x R <sub>sense</sub> )<br>1.20/(10 x R <sub>sense</sub> )<br>1.25/(10 x R <sub>sense</sub> )<br>1.30/(10 x R <sub>sense</sub> )<br>1.35/(10 x R <sub>sense</sub> )<br>1.40/(10 x R <sub>sense</sub> ) | —    | A    |

1. V<sub>OUT</sub> is configurable by LDO\_VTRM[VTRM], it must be lower than 5.2 V. User can check the voltage dropout of MOSFET to avoid over power consumption.
2. This value is affected by the precision of the output voltage divider resistor.
3. N is configured by LDO\_VTRM[VTRM].

### 3.1.2 Programmable gain amplifier (PGA) electronic characterizations

This section includes information about PGA.

**Table 12. PGA electrical characteristics (4.5 V ≤ VDDA ≤ 5.5 V)**

| Symbol               | Description                                      |                    | Min. | Typical | Max. | Unit   |
|----------------------|--------------------------------------------------|--------------------|------|---------|------|--------|
| Gain                 | Programmable gain                                | PGA_CTRL[GAIN]=00b | —    | 8       | —    |        |
|                      |                                                  | PGA_CTRL[GAIN]=01b |      | 10      |      |        |
|                      |                                                  | PGA_CTRL[GAIN]=10b |      | 15      |      |        |
|                      |                                                  | PGA_CTRL[GAIN]=11b |      | 20      |      |        |
| dGain/dT             | Gain versus temperature                          |                    | —    | 10      | —    | ppm/°C |
| V <sub>OS</sub>      | Input referred offset voltage <sup>1</sup>       |                    | -12  | —       | 12   | mV     |
| dV <sub>OS</sub> /dT | Input referred offset voltage versus temperature |                    | —    | 20      | —    | μV/°C  |
| I <sub>IN_BIAS</sub> | Input BIAS current                               |                    | —    | —       | 250  | μA     |
| Bw(-3 dB)            | PGA -3 dB bandwidth                              | PGA_CTRL[GAIN]=00b | —    | —       | 2.0  | MHz    |
|                      |                                                  | PGA_CTRL[GAIN]=01b |      |         | 1.6  |        |
|                      |                                                  | PGA_CTRL[GAIN]=10b |      |         | 1.0  |        |
|                      |                                                  | PGA_CTRL[GAIN]=11b |      |         | 0.8  |        |
| PSRR                 | Power supply rejection ratio                     |                    | —    | -60     | —    | dB     |
| CMRR                 | Common mode rejection ratio                      |                    | —    | -60     | —    | dB     |
| VR_CM_IN             | Input common mode voltage                        |                    | 4.5  | 5       | 5.5  | V      |
| VR_DM_IN             | Input differential mode voltage                  | PGA_CTRL[GAIN]=00b | —    | —       | 250  | mV     |
|                      |                                                  | PGA_CTRL[GAIN]=01b |      |         | 200  |        |
|                      |                                                  | PGA_CTRL[GAIN]=10b |      |         | 130  |        |
|                      |                                                  | PGA_CTRL[GAIN]=11b |      |         | 100  |        |

1. The output referred offset of PGA is digitized by the on-chip ADC and stored in certain memory of each chip, customer can access the data to perform system level calibration.

### 3.1.3 Communication and clamp controller (CNC) electronic characterizations

This section includes information about FSK Zero-Crossing, VREC and VAD analog comparators.

**Table 13. FSK analog comparator electrical specifications**

| Symbol           | Characteristic               |                            | Min.            | Typical | Max.                  | Unit |
|------------------|------------------------------|----------------------------|-----------------|---------|-----------------------|------|
| V <sub>DDA</sub> | Supply voltage               |                            | 3.5             | —       | 5.5                   | V    |
| I <sub>DDA</sub> | Power consumption            |                            | —               | 270     | —                     | μA   |
| V <sub>AIN</sub> | Analog input range           |                            | V <sub>SS</sub> | —       | V <sub>DD</sub> - 1.4 | V    |
| V <sub>AIO</sub> | Analog input offset voltage  |                            | —               | —       | 20                    | mV   |
| V <sub>H</sub>   | Analog comparator hysteresis | CNC_ANACFG1[ZCDHYST] = 00b | —               | 0       | —                     | mV   |
|                  |                              | CNC_ANACFG1[ZCDHYST] = 01b |                 | 18      |                       |      |

**Table 13. FSK analog comparator electrical specifications**

| Symbol | Characteristic             | Min. | Typical | Max. | Unit |
|--------|----------------------------|------|---------|------|------|
|        | CNC_ANACFG1[ZCDHYST] = 10b |      | 40      |      |      |
|        | CNC_ANACFG1[ZCDHYST] = 11b |      | 60      |      |      |

**Table 14. CNC over-voltage protect (OVP) and low-voltage protect (LVP) electrical specifications**

| Symbol                | Characteristic     |                            | Min. | Typical | Max. | Unit |
|-----------------------|--------------------|----------------------------|------|---------|------|------|
| V <sub>REC-OVP</sub>  | VREC OVP assert    | CNC_ANACFG1[VRECOVLVL]=00b | —    | 25.7    | —    | V    |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=01b | 21.5 | 22.5    | 23.2 |      |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=10b | 19.3 | 20.3    | 21.2 |      |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=11b | 16.4 | 17.1    | 18   |      |
| V <sub>REC-OVPR</sub> | VREC OVP de-assert | CNC_ANACFG1[VRECOVLVL]=00b | —    | 20.4    | —    | V    |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=01b | 17   | 17.8    | 18.4 |      |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=10b | 15.2 | 16.2    | 16.8 |      |
|                       |                    | CNC_ANACFG1[VRECOVLVL]=11b | 12.8 | 13.5    | 14   |      |
| V <sub>REC-LVP</sub>  | VREC LVP assert    |                            | 4.3  | 4.5     | 4.7  | V    |
| V <sub>REC-LVPR</sub> | VREC LVP de-assert |                            | 4.9  | 5.1     | 5.3  | V    |
| V <sub>AD-OVP</sub>   | VAD OVP assert     |                            | 5.5  | 5.7     | 5.9  | V    |
| V <sub>AD-OVPR</sub>  | VAD OVP de-assert  |                            | 5.15 | 5.3     | 5.5  | V    |
| V <sub>AD-OK</sub>    | VAD LVP assert     |                            | 4.15 | 4.3     | 4.55 | V    |
| V <sub>AD-OK</sub>    | VAD LVP de-assert  |                            | 3.95 | 4.0     | 4.25 | V    |

## 3.2 Core modules

### 3.2.1 SWD electricals

**Table 15. SWD full voltage range electricals**

| Symbol | Description                                                                                        | Min. | Max. | Unit |
|--------|----------------------------------------------------------------------------------------------------|------|------|------|
| J1     | SWD_CLK frequency of operation <ul style="list-style-type: none"> <li>Serial wire debug</li> </ul> | 0    | 24   | MHz  |
| J2     | SWD_CLK cycle period                                                                               | 1/J1 | —    | ns   |
| J3     | SWD_CLK clock pulse width <ul style="list-style-type: none"> <li>Serial wire debug</li> </ul>      | 20   | —    | ns   |
| J4     | SWD_CLK rise and fall times                                                                        | —    | 3    | ns   |

*Table continues on the next page...*

Table 15. SWD full voltage range electricals (continued)

| Symbol | Description                                     | Min. | Max. | Unit |
|--------|-------------------------------------------------|------|------|------|
| J9     | SWD_DIO input data setup time to SWD_CLK rise   | 10   | —    | ns   |
| J10    | SWD_DIO input data hold time after SWD_CLK rise | 3    | —    | ns   |
| J11    | SWD_CLK high to SWD_DIO data valid              | —    | 35   | ns   |
| J12    | SWD_CLK high to SWD_DIO high-Z                  | 0    | —    | ns   |

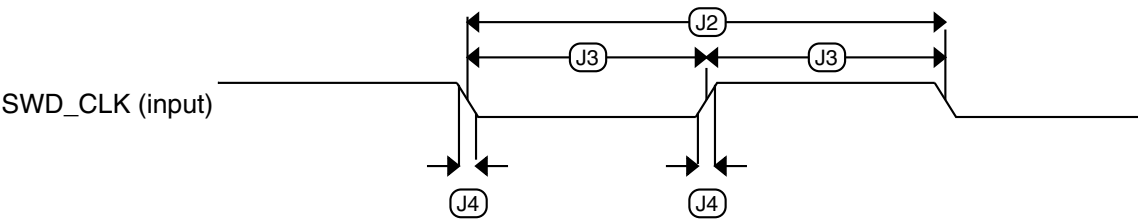


Figure 7. Serial wire clock input timing

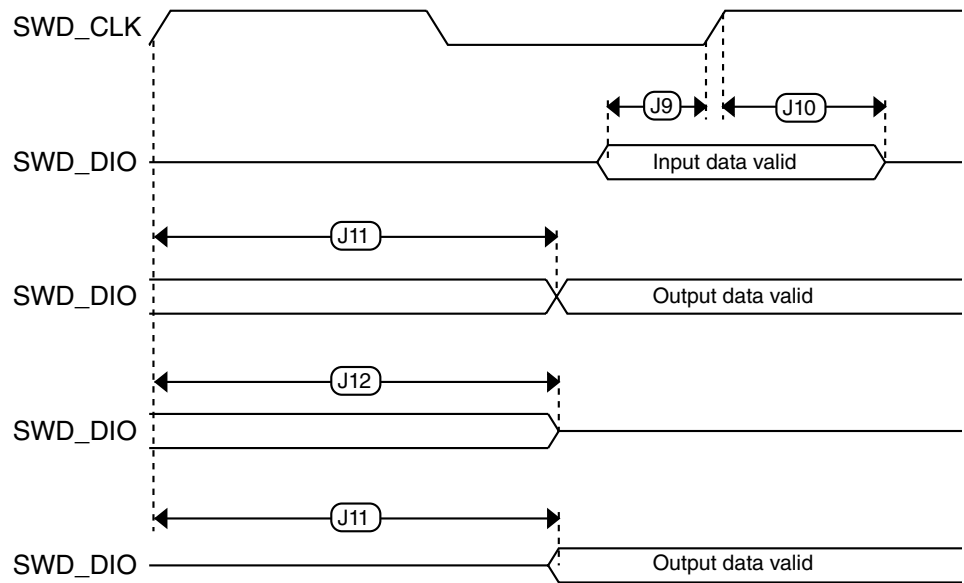


Figure 8. Serial wire data timing

### 3.3 Clock modules

### 3.3.1 External oscillator (OSC) and ICS characteristics

**Table 16. OSC and ICS specifications (temperature range = -40 to 85 °C ambient)**

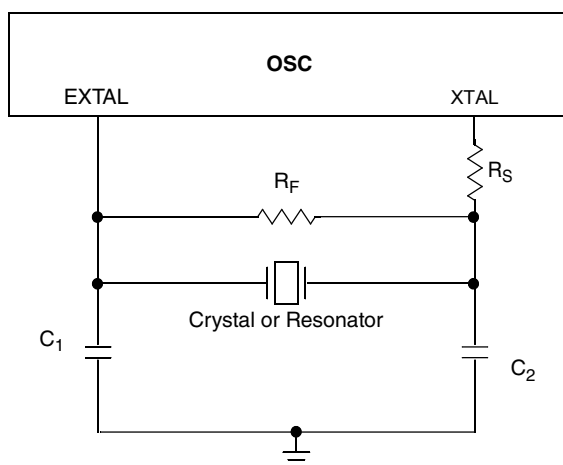
| Characteristic                                                                                   |                                                            | Symbol               | Min                   | Typical <sup>1</sup> | Max     | Unit |
|--------------------------------------------------------------------------------------------------|------------------------------------------------------------|----------------------|-----------------------|----------------------|---------|------|
| Crystal or resonator frequency                                                                   | Low range (RANGE = 0)                                      | $f_{lo}$             | 31.25                 | 32.768               | 39.0625 | kHz  |
|                                                                                                  | High range (RANGE = 1)                                     | $f_{hi}$             | 4                     | —                    | 24      | MHz  |
| Load capacitors                                                                                  |                                                            | C1, C2               | See Note <sup>2</sup> |                      |         |      |
| Feedback resistor                                                                                | Low Frequency, Low-Power Mode <sup>3</sup>                 | $R_F$                | —                     | —                    | —       | MΩ   |
|                                                                                                  | Low Frequency, High-Gain Mode                              |                      | —                     | 10                   | —       | MΩ   |
|                                                                                                  | High Frequency, Low-Power Mode                             |                      | —                     | 1                    | —       | MΩ   |
|                                                                                                  | High Frequency, High-Gain Mode                             |                      | —                     | 1                    | —       | MΩ   |
| Series resistor - Low Frequency                                                                  | Low-Power Mode <sup>3</sup>                                | $R_S$                | —                     | 0                    | —       | kΩ   |
|                                                                                                  | High-Gain Mode                                             |                      | —                     | 200                  | —       | kΩ   |
| Series resistor - High Frequency                                                                 | Low-Power Mode <sup>3</sup>                                | $R_S$                | —                     | 0                    | —       | kΩ   |
| Series resistor - High Frequency, High-Gain Mode                                                 | 4 MHz                                                      |                      | —                     | 0                    | —       | kΩ   |
|                                                                                                  | 8 MHz                                                      |                      | —                     | 0                    | —       | kΩ   |
|                                                                                                  | 16 MHz                                                     |                      | —                     | 0                    | —       | kΩ   |
|                                                                                                  | 24 MHz                                                     |                      | —                     | 0                    | —       | kΩ   |
| Crystal start-up time low range = 32.768 kHz crystal; High range = 24 MHz crystal <sup>4,5</sup> | Low range, low power                                       | $t_{CSTL}$           | —                     | 1000                 | —       | ms   |
|                                                                                                  | Low range, high gain                                       |                      | —                     | 800                  | —       | ms   |
|                                                                                                  | High range, low power                                      | $t_{CSTH}$           | —                     | 3                    | —       | ms   |
|                                                                                                  | High range, high gain                                      |                      | —                     | 1.5                  | —       | ms   |
| Internal reference start-up time                                                                 |                                                            | $t_{IRST}$           | —                     | 20                   | 50      | μs   |
| Internal reference clock (IRC) frequency trim range                                              |                                                            | $f_{int\_t}$         | 31.25                 | —                    | 39.0625 | kHz  |
| Internal reference clock frequency, factory trimmed                                              | T = 25 °C, V <sub>DD</sub> = 5 V                           | $f_{int\_ft}$        | —                     | 37.5                 | —       | kHz  |
| DCO output frequency range                                                                       | FLL reference = $f_{int\_t}$ , $f_{lo}$ , or $f_{hi}/RDIV$ | $f_{dco}$            | 40                    | —                    | 50      | MHz  |
| Factory trimmed internal oscillator accuracy                                                     | T = 25 °C, V <sub>DD</sub> = 5 V                           | $\Delta f_{int\_ft}$ | -0.5                  | —                    | 0.5     | %    |
| Deviation of IRC over temperature when trimmed at T = 25 °C, V <sub>DD</sub> = 5 V               | Over temperature range from -40 °C to 85 °C                | $\Delta f_{int\_t}$  | -1                    | —                    | 0.5     | %    |
|                                                                                                  | Over temperature range from 0 °C to 85 °C                  | $\Delta f_{int\_t}$  | -0.5                  | —                    | 0.5     |      |
| Frequency accuracy of DCO output using factory trim value                                        | Over temperature range from -40 °C to 85 °C                | $\Delta f_{dco\_ft}$ | -2                    | —                    | 1.5     | %    |
|                                                                                                  | Over temperature range from 0 °C to 85 °C                  | $\Delta f_{dco\_ft}$ | -1                    | —                    | 1.5     |      |

Table continues on the next page...

**Table 16. OSC and ICS specifications (temperature range = -40 to 85 °C ambient)  
(continued)**

| Characteristic                                                                  | Symbol        | Min | Typical <sup>1</sup> | Max | Unit        |
|---------------------------------------------------------------------------------|---------------|-----|----------------------|-----|-------------|
| FLL acquisition time <sup>4,6</sup>                                             | $t_{Acquire}$ | —   | —                    | 2   | ms          |
| Long term jitter of DCO output clock (averaged over 2 ms interval) <sup>7</sup> | $C_{Jitter}$  | —   | 0.02                 | 0.2 | % $f_{dco}$ |

1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
2. See crystal or resonator manufacturer's recommendation.
3. Load capacitors ( $C_1, C_2$ ), feedback resistor ( $R_F$ ) and series resistor ( $R_S$ ) are incorporated internally when RANGE = HGO = 0.
4. This parameter is characterized and not tested on each device.
5. Proper PC board layout procedures must be followed to achieve specifications.
6. This specification applies to any time the FLL reference source or reference divider is changed, trim value changed, or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
7. Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum  $f_{BUS}$ . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via  $V_{DD}$  and  $V_{SS}$  and variation in crystal oscillator frequency increase the  $C_{Jitter}$  percentage for a given interval.

**Figure 9. Typical crystal or resonator circuit**

## 3.4 Memories and memory interfaces

### 3.4.1 NVM specifications

This section provides details about program / erase times, program / erase endurance for the flash memory.

**Table 17. Flash characteristics**

| Characteristic                                                                                                           | Symbol               | Min. <sup>1</sup> | Typical <sup>2</sup> | Max. <sup>3</sup> | Unit <sup>4</sup> |
|--------------------------------------------------------------------------------------------------------------------------|----------------------|-------------------|----------------------|-------------------|-------------------|
| NVM Bus frequency                                                                                                        | f <sub>NVMBUS</sub>  | 1                 | —                    | 25                | MHz               |
| NVM Operating frequency                                                                                                  | f <sub>NVMOP</sub>   | 0.8               | 1                    | 1.05              | MHz               |
| Erase Verify All Blocks                                                                                                  | t <sub>VFYALL</sub>  | —                 | —                    | 4653              | t <sub>CYC</sub>  |
| Erase Verify Flash Block                                                                                                 | t <sub>RD1BLK</sub>  | —                 | —                    | 4626              | t <sub>CYC</sub>  |
| Erase Verify Flash Section                                                                                               | t <sub>RD1SEC</sub>  | —                 | —                    | 482               | t <sub>CYC</sub>  |
| Read Once                                                                                                                | t <sub>RDONCE</sub>  | —                 | —                    | 464               | t <sub>CYC</sub>  |
| Program Flash (2 words)                                                                                                  | t <sub>PGM2</sub>    | 0.14              | 0.14                 | 0.35              | ms                |
| Program Flash (4 words)                                                                                                  | t <sub>PGM4</sub>    | 0.23              | 0.23                 | 0.56              | ms                |
| Program Once                                                                                                             | t <sub>PGMONCE</sub> | 0.22              | 0.23                 | 0.23              | ms                |
| Erase All Blocks                                                                                                         | t <sub>ERSALL</sub>  | 95.54             | 100.31               | 100.56            | ms                |
| Erase Flash Block                                                                                                        | t <sub>ERSBLK</sub>  | 95.54             | 100.31               | 100.56            | ms                |
| Erase Flash Sector                                                                                                       | t <sub>ERSPG</sub>   | 19.11             | 20.06                | 20.10             | ms                |
| Unsecure Flash                                                                                                           | t <sub>UNSECU</sub>  | 95.55             | 100.31               | 100.57            | ms                |
| Configure NVM                                                                                                            | t <sub>CONFNVM</sub> | —                 | —                    | 381               | t <sub>CYC</sub>  |
| Verify Backdoor Access Key                                                                                               | t <sub>VFYKEY</sub>  | —                 | —                    | 482               | t <sub>CYC</sub>  |
| Set User Margin Level                                                                                                    | t <sub>MLOADU</sub>  | —                 | —                    | 420               | t <sub>CYC</sub>  |
| FLASH Program/erase endurance T <sub>L</sub> to T <sub>H</sub> = -40 °C to 105 °C                                        | n <sub>FLPE</sub>    | 10 k              | 100 k                | —                 | Cycles            |
| Data retention at an average junction temperature of T <sub>JAVG</sub> = 85 °C after up to 10,000 program / erase cycles | t <sub>D_RET</sub>   | 15                | 100                  | —                 | years             |

1. Minimum times are based on maximum f<sub>NVMOP</sub> and maximum f<sub>NVMBUS</sub>
2. Typical times are based on typical f<sub>NVMOP</sub> and maximum f<sub>NVMBUS</sub>
3. Maximum times are based on typical f<sub>NVMOP</sub> and typical f<sub>NVMBUS</sub> plus aging
4. t<sub>CYC</sub> = 1 / f<sub>NVMBUS</sub>

Program and erase operations do not require any special power sources other than the normal V<sub>DD</sub> supply. For more detailed information about program and erase operations, see the Memory section.

## 3.5 Analog

### 3.5.1 IFR measurement conditions

The value stored in the IFR is measured under the conditions of the following table.

**Table 18. IFR measurement conditions**

| Symbol     | Descriptions                                    | Value    | Unit |
|------------|-------------------------------------------------|----------|------|
| $V_{REFH}$ | ADC reference voltage                           | 5        | V    |
| $V_{REC}$  | Supply voltage from wireless receiver rectifier | 5        | V    |
| $V_{DDX}$  | I/O supply voltage                              | 5        | V    |
| $f_{BUS}$  | Bus frequency                                   | 24       | MHz  |
| $T_A$      | Ambient temperature                             | 25       | °C   |
| —          | Code execution                                  | From RAM | —    |
| —          | NVM activity                                    | —        | —    |

### 3.5.2 ADC characteristics

This section describes the ADC characteristics.

**Table 19. ADC Operating Conditions**

| Characteristic                                                                     |                   | Symbol            | Min           | Typ | Max           | Unit             |
|------------------------------------------------------------------------------------|-------------------|-------------------|---------------|-----|---------------|------------------|
| Reference potential                                                                | Low               | $V_{RL}$          | $V_{SSA}$     | —   | $V_{DDA} / 2$ | V                |
|                                                                                    | High              | $V_{RH}$          | $V_{DDA} / 2$ | —   | $V_{DDA}$     | V                |
| Differential reference voltage <sup>1</sup>                                        |                   | $V_{RH} - V_{RL}$ | 3.13          | 5.0 | 5.5           | V                |
| ADC Clock Frequency (derived from bus clock via the prescaler bus)                 |                   | $f_{ATDCLK}$      | 0.25          | —   | 8.33          | MHz              |
| Buffer amplifier turn on time (delay after module start / recovery from Stop mode) |                   | $t_{REC}$         | —             | —   | 1             | μs               |
| ADC disable time                                                                   |                   | $t_{DISABLE}$     | —             | —   | 3             | bus clock cycles |
| ADC Conversion Period <sup>2</sup>                                                 | 12-bit resolution | $N_{CONV12}$      | 19            | —   | 39            | ADC clock cycles |
|                                                                                    | 10-bit resolution | $N_{CONV10}$      | 18            | —   | 38            |                  |
|                                                                                    | 8-bit resolution  | $N_{CONV8}$       | 16            | —   | 36            |                  |

1. Full accuracy is not guaranteed when differential voltage is less than 4.50 V.

2. The minimum time assumes a sample time of four ATD clock cycles. The maximum time assumes a sample time of 24 ATD clock cycles.



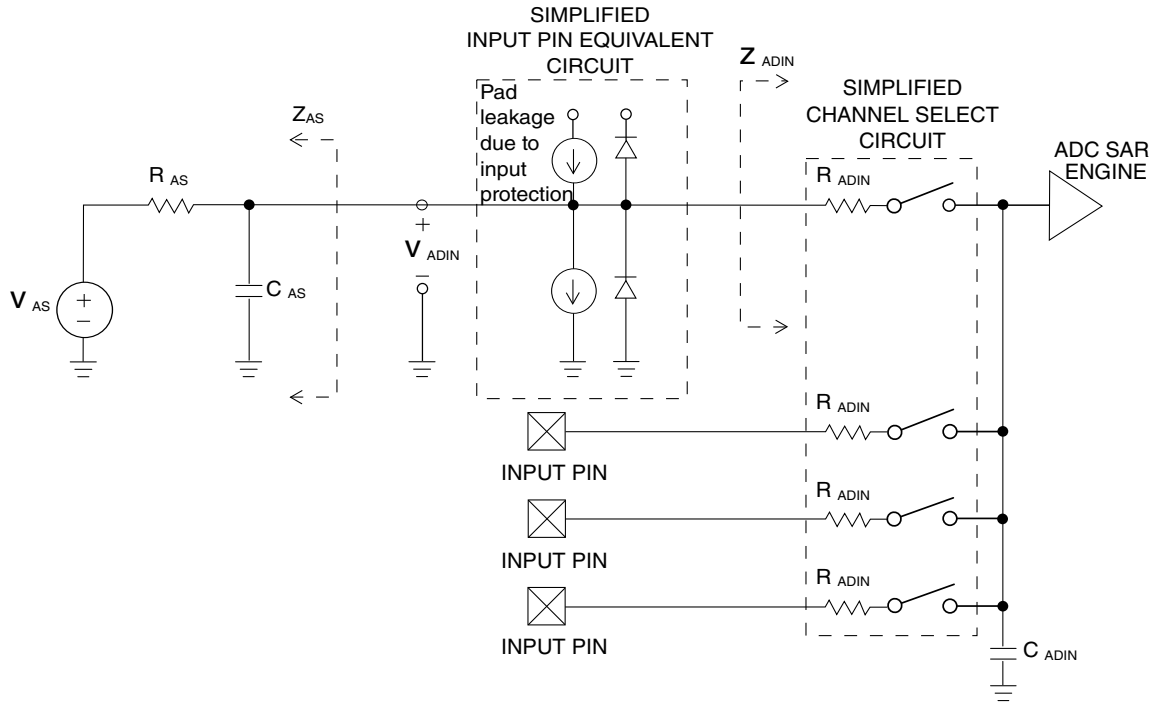


Figure 10. ADC Input Impedance Equivalency Diagram

Table 20. ADC Electrical Characteristics

| Characteristic                            | Symbol    | Min  | Typical | Max  | Unit       |
|-------------------------------------------|-----------|------|---------|------|------------|
| Max input source resistance               | $R_S$     | —    | —       | 1    | K $\Omega$ |
| Total input capacitance Non sampling      | $C_{INN}$ | —    | —       | 10   | pF         |
| Total input capacitance sampling          | $C_{INS}$ | —    | —       | 16   | pF         |
| Input internal Resistance                 | $R_{INA}$ | —    | 5       | 15   | K $\Omega$ |
| Disruptive analog input current           | $I_{NA}$  | 0.25 | —       | 2.5  | mA         |
| Coupling ratio positive current injection | $K_p$     | —    | —       | 1E-4 | A/A        |
| Coupling ratio negative current injection | $K_n$     | —    | —       | 5E-3 | A/A        |

Table 21. ADC Conversion Performance

| Characteristic <sup>1</sup> |        | Symbol | Min  | Typical   | Max | Unit   |
|-----------------------------|--------|--------|------|-----------|-----|--------|
| Resolution                  | 12-Bit | LSB    | —    | 1.25      | —   | mV     |
| Differential Nonlinearity   | 12-Bit | DNL    | -4   | $\pm 2$   | 4   | counts |
| Integral Nonlinearity       | 12-Bit | INL    | -5   | $\pm 2.5$ | 5   | counts |
| Absolute Error <sup>2</sup> | 12-Bit | AE     | -7   | $\pm 4$   | 7   | counts |
| Resolution                  | 10-Bit | LSB    | —    | 5         | —   | mV     |
| Differential Nonlinearity   | 10-Bit | DNL    | -1   | $\pm 0.5$ | 1   | counts |
| Integral Nonlinearity       | 10-Bit | INL    | -2.5 | $\pm 1$   | 2.5 | counts |
| Absolute Error <sup>2</sup> | 10-Bit | AE     | -3   | $\pm 2$   | 3   | counts |

Table continues on the next page...

**Table 21. ADC Conversion Performance (continued)**

| Characteristic <sup>1</sup> |       | Symbol | Min  | Typical | Max | Unit   |
|-----------------------------|-------|--------|------|---------|-----|--------|
| Resolution                  | 8-Bit | LSB    | —    | 20      | —   | mV     |
| Differential Non-linearity  | 8-Bit | DNL    | -0.5 | ±0.3    | 0.5 | counts |
| Integral Non-linearity      | 8-Bit | INL    | -1   | ±0.5    | 1   | counts |
| Absolute Error <sup>2</sup> | 8-Bit | AE     | -1.5 | ±1      | 1.5 | counts |

1. The 8-bit and 10-bit mode operation is structurally tested in production test. Absolute values are tested in 12-bit mode.

2. These values include the quantization error which is inherently 1/2 count for any ADC.

**NOTE**

Supply voltage  $V_{DDA} = 5.12$  V. External  $V_{REF} = V_{RH} - V_{RL} = 5.12$  V.  $f_{ADCCLK} = 8.0$  MHz The values are tested to be valid with no IO PORT output drivers switching simultaneous with conversions.

**3.5.3 Analog comparator (ACMP) electricals****Table 22. Comparator electrical specifications**

| Characteristic                                      | Symbol       | Min            | Typical | Max       | Unit             |
|-----------------------------------------------------|--------------|----------------|---------|-----------|------------------|
| Supply current (Operation mode)                     | $I_{DDA}$    | —              | 10      | 20        | μA               |
| Supply current, low-speed mode (EN = 1, PMODE = 0)  | $I_{DDL5}$   | —              | 18      | 20        | μA               |
| Analog input voltage                                | $V_{AIN}$    | $V_{SS} - 0.3$ | —       | $V_{DDA}$ | V                |
| Analog input offset voltage                         | $V_{AIO}$    | —              | —       | 40        | mV               |
| Analog comparator hysteresis (HYST=0)               | $V_H$        | —              | 15      | 20        | mV               |
| Analog comparator hysteresis (HYST=1)               | $V_H$        | —              | 20      | 30        | mV               |
| Analog comparator initialization delay <sup>1</sup> |              | —              | —       | 40        | μs               |
| Supply current (Off mode)                           | $I_{DDAOFF}$ | —              | 60      | —         | nA               |
| 6-bit DAC current adder (enabled)                   | $I_{DAC6b}$  | —              | 7       | —         | μA               |
| Propagation Delay                                   | $t_D$        | —              | 0.4     | 1         | μs               |
| 6-bit DAC integral non-linearity                    | INL          | -0.5           | —       | 0.5       | LSB <sup>2</sup> |
| 6-bit DAC differential non-linearity                | DNL          | -0.3           | —       | 0.3       | LSB <sup>2</sup> |

1. Comparator initialization delay is defined as the time between software writes to change control inputs (writes to DACEN, VRSEL, PSEL, MSEL, VOSEL) and the comparator output settling to a stable level.

2.  $1 \text{ LSB} = V_{\text{reference}}/64$

## 3.6 Communication interfaces

### 3.6.1 Inter-Integrated Circuit Interface (I2C) timing

Table 23. I2C timing

| Characteristic                                                                               | Symbol                      | Standard Mode    |                   | Fast Mode <sup>1</sup>     |                  | Unit          |
|----------------------------------------------------------------------------------------------|-----------------------------|------------------|-------------------|----------------------------|------------------|---------------|
|                                                                                              |                             | Minimum          | Maximum           | Minimum                    | Maximum          |               |
| SCL Clock Frequency                                                                          | $f_{\text{SCL}}$            | 0                | 100               | 0                          | 400 <sup>2</sup> | kHz           |
| Hold time (repeated) START condition. After this period, the first clock pulse is generated. | $t_{\text{HD}}; \text{STA}$ | 4                | —                 | 0.6                        | —                | $\mu\text{s}$ |
| LOW period of the SCL clock                                                                  | $t_{\text{LOW}}$            | 4.7              | —                 | 1.3                        | —                | $\mu\text{s}$ |
| HIGH period of the SCL clock                                                                 | $t_{\text{HIGH}}$           | 4                | —                 | 0.6                        | —                | $\mu\text{s}$ |
| Set-up time for a repeated START condition                                                   | $t_{\text{SU}}; \text{STA}$ | 4.7              | —                 | 0.6                        | —                | $\mu\text{s}$ |
| Data hold time for I <sup>2</sup> C bus devices                                              | $t_{\text{HD}}; \text{DAT}$ | 0 <sup>3</sup>   | 3.45 <sup>4</sup> | 0 <sup>5</sup>             | 0.9 <sup>3</sup> | $\mu\text{s}$ |
| Data set-up time                                                                             | $t_{\text{SU}}; \text{DAT}$ | 250 <sup>6</sup> | —                 | 100 <sup>4, 7</sup>        | —                | ns            |
| Rise time of SDA and SCL signals                                                             | $t_r$                       | —                | 1000              | $20 + 0.1C_b$ <sup>8</sup> | 300              | ns            |
| Fall time of SDA and SCL signals                                                             | $t_f$                       | —                | 300               | $20 + 0.1C_b$ <sup>7</sup> | 300              | ns            |
| Set-up time for STOP condition                                                               | $t_{\text{SU}}; \text{STO}$ | 4                | —                 | 0.6                        | —                | $\mu\text{s}$ |
| Bus free time between STOP and START condition                                               | $t_{\text{BUF}}$            | 4.7              | —                 | 1.3                        | —                | $\mu\text{s}$ |
| Pulse width of spikes that must be suppressed by the input filter                            | $t_{\text{SP}}$             | N/A              | N/A               | 0                          | 50               | ns            |

1. Fast mode is fully supported on all pins at  $V_{\text{DD}} > 2.7 \text{ V}$ . If  $V_{\text{DD}} < 2.7 \text{ V}$ , only pins that support high drive strength can support fast mode with maximum bus loading.
2. The maximum SCL Clock Frequency in Fast mode with maximum bus loading can only be achieved when using the High drive pins (see [Voltage and current operating behaviors](#)) or when using the Normal drive pins and  $V_{\text{DD}} \geq 2.7 \text{ V}$ .
3. The master mode I<sup>2</sup>C deasserts ACK of an address byte simultaneously with the falling edge of SCL. If no slaves acknowledge this address byte, then a negative hold time can result, depending on the edge rates of the SDA and SCL lines.
4. The maximum  $t_{\text{HD}}; \text{DAT}$  must be met only if the device does not stretch the LOW period ( $t_{\text{LOW}}$ ) of the SCL signal.
5. Input signal Slew = 10 ns and Output Load = 50 pF
6. Set-up time in slave-transmitter mode is 1 IPBus clock period, if the TX FIFO is empty.
7. A Fast mode I<sup>2</sup>C bus device can be used in a Standard mode I<sup>2</sup>C bus system, but the requirement  $t_{\text{SU}}; \text{DAT} \geq 250 \text{ ns}$  must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, then it must output the next data bit to the SDA line  $t_{\text{rmax}} + t_{\text{SU}}; \text{DAT} = 1000 + 250 = 1250 \text{ ns}$  (according to the Standard mode I<sup>2</sup>C bus specification) before the SCL line is released.
8.  $C_b$  = total capacitance of the one bus line in pF.

Dimensions

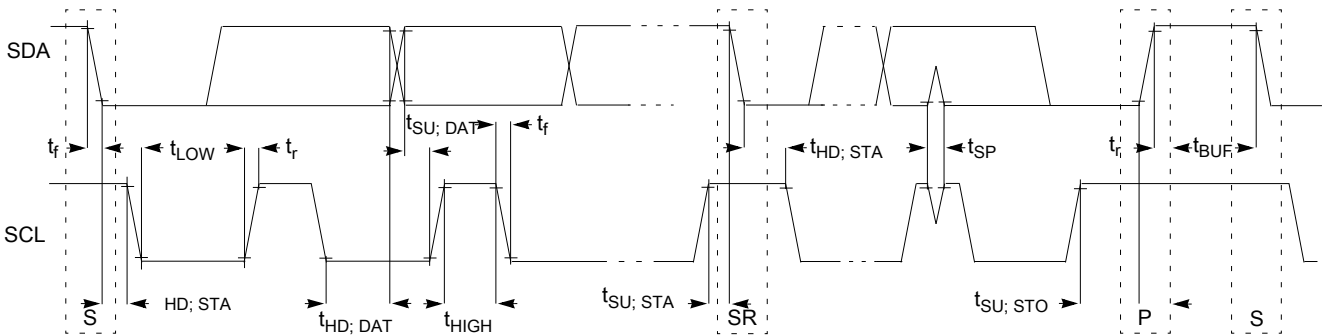


Figure 11. Timing definition for fast and standard mode devices on the I<sup>2</sup>C bus

4 Dimensions

4.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to [freescale.com](http://freescale.com) and perform a keyword search for the drawing's document number:

| If you want the drawing for this package | Then use this document number |
|------------------------------------------|-------------------------------|
| 32-pin QFN                               | 98ASA00615D                   |
| 36-pin WLCSP                             | 98ASA00789D                   |

5 Pinout

5.1 Signal multiplexing and pin assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document.

NOTE

VDD1 and VDD2 must be short on PCB.

PTA6 and PTA7 are true open drain pins. The external pullup resistor must be added to make them output correct values in using I2C0, GPIO, and UART0.

The NC pin must be floating, and do not tie it to the any of the VDD or VSS.

| 32<br>QFN | 36<br>WLC<br>SP | Pin Name                   | Default       | ALT0          | ALT1      | ALT2      | ALT3     |
|-----------|-----------------|----------------------------|---------------|---------------|-----------|-----------|----------|
| —         | C3              | VSS1                       | VSS1          | VSS1          |           |           |          |
| —         | C4              | VSS1                       | VSS1          | VSS1          |           |           |          |
| —         | D3              | VDD1                       | VDD1          | VDD1          |           |           |          |
| —         | D4              | VDD1                       | VDD1          | VDD1          |           |           |          |
| 1         | A1              | VREC                       | VREC          | VREC          |           |           |          |
| 2         | A2              | VDD1                       | VDD1          | VDD1          |           |           |          |
| 3         | A3              | VSS1                       | VSS1          | VSS1          |           |           |          |
| 4         | B3              | PTA0                       | DISABLED      | PTA0          | SBAR_IN1  | EXTAL     |          |
| 5         | B4              | PTA1                       | DISABLED      | PTA1          | SBAR_OUT0 | XTAL      |          |
| 6         | A4              | PTA2                       | DISABLED      | PTA2          | BUSOUT    | SBAR_OUT1 | FTM0_CH0 |
| 7         | A5              | PTA3                       | DISABLED      | PTA3          | CLAMP     | ACMP0_OUT | FTM0_CH1 |
| 8         | A6              | PTA4                       | SWDIO         | PTA4          | SWDIO     |           | FTM1_CH0 |
| 9         | B6              | PTA5                       | SWCLK         | PTA5          | SWCLK     |           | FTM1_CH1 |
| 10        | B5              | PTA6                       | DISABLED      | PTA6          | I2C0_SDA  | UART0_RX  |          |
| 11        | C5              | PTA7                       | DISABLED      | PTA7          | I2C0_SCL  | UART0_TX  |          |
| 12        | C6              | VSS2/<br>VSSA              | VSS2/<br>VSSA | VSS2/<br>VSSA |           |           |          |
| 13        | D6              | VDD2/<br>VDDA              | VDD2/<br>VDDA | VDD2/<br>VDDA |           |           |          |
| 14        | E6              | PTB0/<br>RESET_b/<br>NMI_b | RESET_b       | PTB0          | IRQ       | NMI_b     | RESET_b  |
| 15        | D5              | PTB1                       | DISABLED      | PTB1          | ADCAD0    | SBAR_IN0  |          |
| 16        | E5              | PTB2                       | DISABLED      | PTB2          | ADCAD1    | ACMP0_IN0 |          |
| 17        | F6              | PTB3                       | DISABLED      | PTB3          | ADCAD2    | ACMP0_IN1 |          |
| 18        | E4              | PTB4                       | DISABLED      | PTB4          | ADCAD3    |           |          |
| 19        | F5              | VSS3                       | VSS3          | VSS3          |           |           |          |
| 20        | F4              | VREFH                      | VREFH         | VREFH         |           |           |          |
| 21        | F3              | VOUT_FB                    | VOUT_FB       | VOUT_FB       |           |           |          |
| 23        | F2              | VOUT                       | VOUT          | VOUT          |           |           |          |
| 24        | F1              | ISENS                      | ISENS         | ISENS         |           |           |          |
| 25        | E2              | CLC1                       | CLC1          | CLC1          |           |           |          |
| 26        | D2              | VLC                        | VLC           | VLC           |           |           |          |
| 27        | E1              | GD                         | GD            | GD            |           |           |          |
| 28        | D1              | VBOOT                      | VBOOT         | VBOOT         |           |           |          |
| 29        | C2              | AD_IN                      | AD_IN         | AD_IN         |           |           |          |
| 30        | B2              | AD_EN                      | AD_EN         | AD_EN         |           |           |          |

Pinout

| 32<br>QFN | 36<br>WLC<br>SP | Pin Name | Default | ALT0 | ALT1 | ALT2 | ALT3 |
|-----------|-----------------|----------|---------|------|------|------|------|
| 31        | C1              | AC1      | AC1     | AC1  |      |      |      |
| 32        | B1              | AC2      | AC2     | AC2  |      |      |      |

5.2 Device pin assignment

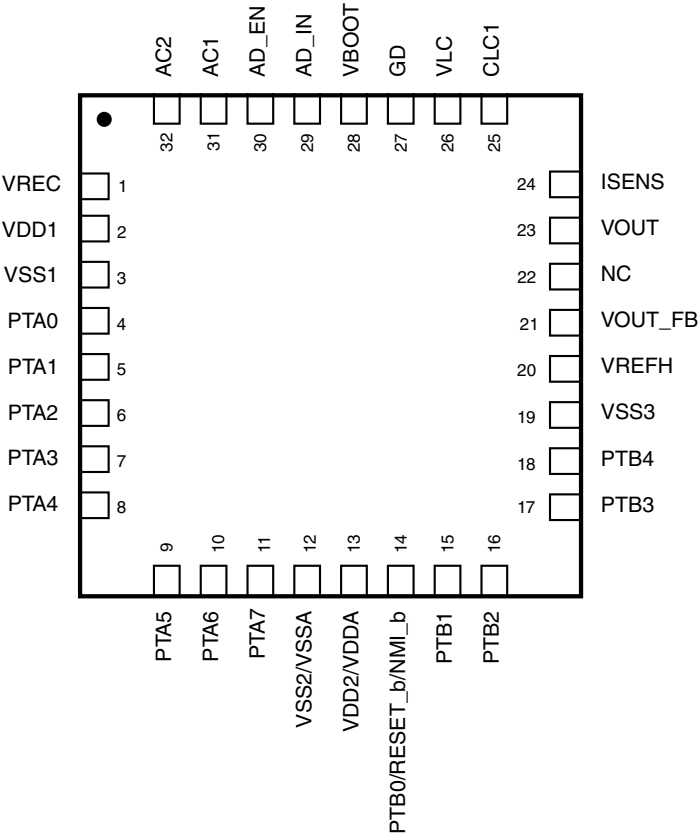


Figure 12. 32-pin QFN package

NOTE

The NC pin must be floating, and do not tie it to the VDD or VSS.

|   | 1     | 2     | 3       | 4     | 5    | 6                          |   |
|---|-------|-------|---------|-------|------|----------------------------|---|
| A | VREC  | VDD1  | VSS1    | PTA2  | PTA3 | PTA4                       | A |
| B | AC2   | AD_EN | PTA0    | PTA1  | PTA6 | PTA5                       | B |
| C | AC1   | AD_IN | VSS1    | VSS1  | PTA7 | VSS2/<br>VSSA              | C |
| D | VBOOT | VLC   | VDD1    | VDD1  | PTB1 | VDD2/<br>VDDA              | D |
| E | GD    | CLC1  | CLC2    | PTB4  | PTB2 | PTB0/<br>RESET_b/<br>NMI_b | E |
| F | ISENS | VOUT  | VOUT_FB | VREFH | VSS3 | PTB3                       | F |
|   | 1     | 2     | 3       | 4     | 5    | 6                          |   |

Figure 13. 36-pin WLCSP package

## 6 Ordering Parts

### 6.1 Determining valid orderable parts

Valid orderable part numbers are provided on the web. To determine the orderable part numbers for this device, go to [freescale.com](http://freescale.com) and perform a part number search for the following device numbers: WPR1516.

## 7 Part Identification

### 7.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

### 7.2 Format

Part numbers for this device have the following format:

Q WPR## FFF R T PP N

## 7.3 Fields

This table lists the possible values for each field in the part number (not all combinations are valid):

| Field | Description               | Values                                                                                                                   |
|-------|---------------------------|--------------------------------------------------------------------------------------------------------------------------|
| Q     | Qualification status      | <ul style="list-style-type: none"> <li>M = Fully qualified, general market flow</li> <li>P = Prequalification</li> </ul> |
| WPR## | WPR family                | <ul style="list-style-type: none"> <li>WPR15</li> </ul>                                                                  |
| FFF   | Program flash memory size | <ul style="list-style-type: none"> <li>16 = 16 KB</li> </ul>                                                             |
| R     | Silicon revision          | <ul style="list-style-type: none"> <li>(Blank) = Main</li> <li>A = Revision after main</li> </ul>                        |
| T     | Temperature range (°C)    | <ul style="list-style-type: none"> <li>C = -40 to 85 °C</li> </ul>                                                       |
| PP    | Package identifier        | <ul style="list-style-type: none"> <li>FM=32 QFN (5 mm x 5 mm)</li> <li>AL=36 WLCSP (3.1 mm x 3.0 mm)</li> </ul>         |
| N     | Packaging type            | <ul style="list-style-type: none"> <li>R = Tape and reel</li> <li>(Blank) = Trays</li> </ul>                             |

## 7.4 Example

This is an example part number:

MWPR1516CFM

## 8 Terminology and guidelines

### 8.1 Definition: Operating requirement

An *operating requirement* is a specified value or range of values for a technical characteristic that you must guarantee during operation to avoid incorrect operation and possibly decreasing the useful life of the chip.

#### 8.1.1 Example

This is an example of an operating requirement:



| Symbol          | Description               | Min. | Max. | Unit |
|-----------------|---------------------------|------|------|------|
| V <sub>DD</sub> | 1.0 V core supply voltage | 0.9  | 1.1  | V    |

## 8.2 Definition: Operating behavior

Unless otherwise specified, an *operating behavior* is a specified value or range of values for a technical characteristic that are guaranteed during operation if you meet the operating requirements and any other specified conditions.

### 8.2.1 Example

This is an example of an operating behavior:

| Symbol          | Description                              | Min. | Max. | Unit |
|-----------------|------------------------------------------|------|------|------|
| I <sub>WP</sub> | Digital I/O weak pullup/pulldown current | 10   | 130  | μA   |

## 8.3 Definition: Attribute

An *attribute* is a specified value or range of values for a technical characteristic that are guaranteed, regardless of whether you meet the operating requirements.

### 8.3.1 Example

This is an example of an attribute:

| Symbol | Description                     | Min. | Max. | Unit |
|--------|---------------------------------|------|------|------|
| CIN_D  | Input capacitance: digital pins | —    | 7    | pF   |

## 8.4 Definition: Rating

A *rating* is a minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure:

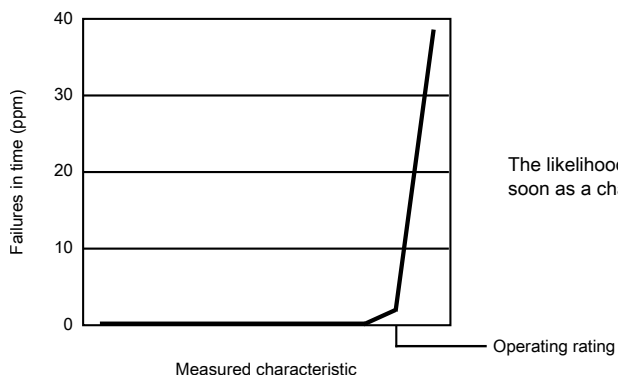
- *Operating ratings* apply during operation of the chip.
- *Handling ratings* apply when the chip is not powered.

### 8.4.1 Example

This is an example of an operating rating:

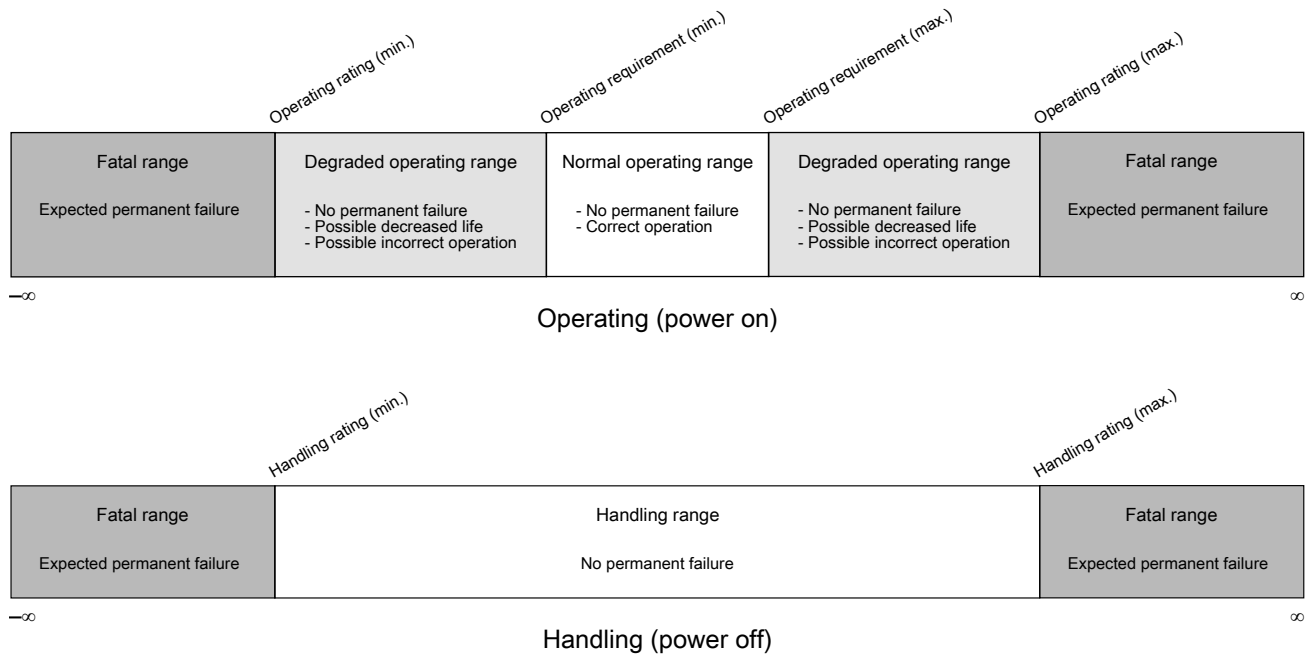
| Symbol   | Description               | Min. | Max. | Unit |
|----------|---------------------------|------|------|------|
| $V_{DD}$ | 1.0 V core supply voltage | -0.3 | 1.2  | V    |

## 8.5 Result of exceeding a rating



The likelihood of permanent chip failure increases rapidly as soon as a characteristic begins to exceed one of its operating ratings.

## 8.6 Relationship between ratings and operating requirements



## 8.7 Guidelines for ratings and operating requirements

Follow these guidelines for ratings and operating requirements:

- Never exceed any of the chip's ratings.
- During normal operation, don't exceed any of the chip's operating requirements.
- If you must exceed an operating requirement at times other than during normal operation (for example, during power sequencing), limit the duration as much as possible.

## 8.8 Definition: Typical value

A *typical value* is a specified value for a technical characteristic that:

- Lies within the range of values specified by the operating behavior
- Given the typical manufacturing process, is representative of that characteristic during operation when you meet the typical-value conditions or other specified conditions

Typical values are provided as design guidelines and are neither tested nor guaranteed.

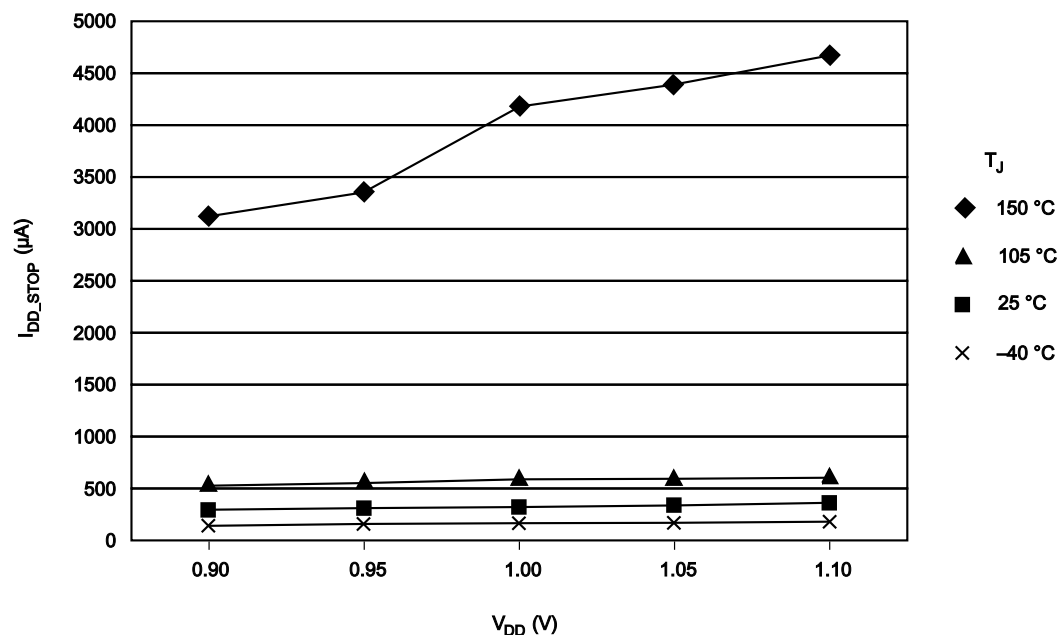
### 8.8.1 Example 1

This is an example of an operating behavior that includes a typical value:

| Symbol   | Description                              | Min. | Typ. | Max. | Unit    |
|----------|------------------------------------------|------|------|------|---------|
| $I_{WP}$ | Digital I/O weak pullup/pulldown current | 10   | 70   | 130  | $\mu A$ |

### 8.8.2 Example 2

This is an example of a chart that shows typical values for various voltage and temperature conditions:



## 8.9 Typical value conditions

Typical values assume you meet the following conditions (or other conditions as specified):

**Table 24. Typical value conditions**

| Symbol   | Description          | Value | Unit |
|----------|----------------------|-------|------|
| $T_A$    | Ambient temperature  | 25    | °C   |
| $V_{DD}$ | 3.3 V supply voltage | 3.3   | V    |

## 9 Revision history

The following table provides a revision history for this document.

**Table 25. Revision history**

| Rev. No. | Date   | Substantial Changes     |
|----------|--------|-------------------------|
| 2        | 1/2015 | Initial public release. |

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